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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

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Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







Power MOSFET

40 V, 3.7 m Ω , 87 A, Single N-Channel

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5C456NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	40	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	Steady State	T _C = 25°C	I _D	87	Α
Current R _{θJC} (Notes 1, 3)		T _C = 100°C		61	
Power Dissipation		T _C = 25°C	P_{D}	55	W
R _{θJC} (Note 1)		T _C = 100°C		27	
Continuous Drain		T _A = 25°C	I _D	22	Α
Current R _{0JA} (Notes 1, 2, 3)	Steady	T _A = 100°C		16	
Power Dissipation	State	T _A = 25°C	P_{D}	3.6	W
R _{θJA} (Notes 1 & 2)		T _A = 100°C		1.8	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	520	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to + 175	°C
Source Current (Body Diode)			I _S	61	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 5 A)			E _{AS}	202	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	2.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	42	

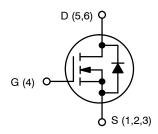
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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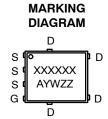
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX		
40 V	3.7 m Ω @ 10 V	87 A		
	6.0 mΩ @ 4.5 V	07 A		



N-CHANNEL MOSFET



DFN5 (SO-8FL) CASE 488AA STYLE 1



XXXXXX = 5C456L

(NVMFS5C456NL) or

456LWF

(NVMFS5C456NLWF)

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	_			•	•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				22		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25 °C			10	,
		$V_{DS} = 40 \text{ V}$	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V	I _D = 20 A		4.8	6.0	
		V _{GS} = 10 V	I _D = 20 A		3.1	3.7	mΩ
Forward Transconductance	9FS	V _{DS} =15 V, I _D = 40 A			80		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE				-		
Input Capacitance	C _{ISS}				1600		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			590		pF
Reverse Transfer Capacitance	C _{RSS}				21		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 40 A			18		nC
Total Gate Charge	Q _{G(TOT)}				8.2		nC
Threshold Gate Charge	Q _{G(TH)}				2		
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 3.5 \text{ V}$	20 V; I _D = 40 A		3.8		
Gate-to-Drain Charge	Q_{GD}	as r se r s			2.1		1
Plateau Voltage	V _{GP}				3.2		V
SWITCHING CHARACTERISTICS (Note 5)				•		•
Turn-On Delay Time	t _{d(ON)}				9.3		
Rise Time	t _r	V _{GS} = 4.5 V, V _E	ne = 20 V.		100		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 40 \text{ A}, R_G = 1 \Omega$			17		ns
Fall Time	t _f				4		
DRAIN-SOURCE DIODE CHARACTERIS	TICS			ı		ı	
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 40 A	T _J = 25°C		0.86	1.2	
			T _J = 125°C		0.75		-
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt} = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 40 \text{ A}$			29		ns
Charge Time	t _a				14		
Discharge Time	t _b				15		
Reverse Recovery Charge	Q _{RR}				20		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

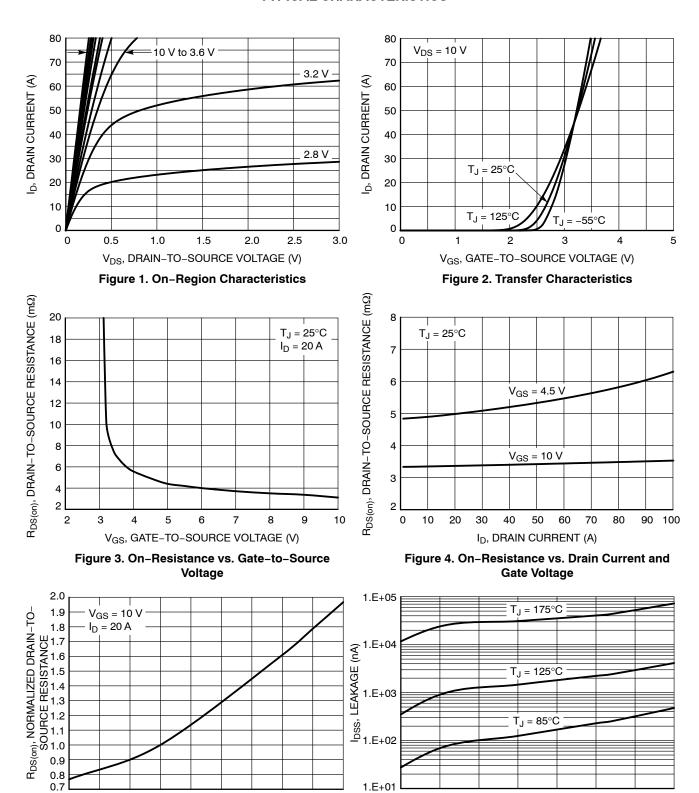


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

75

100

150

175

50

-25

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

40

20

15

TYPICAL CHARACTERISTICS

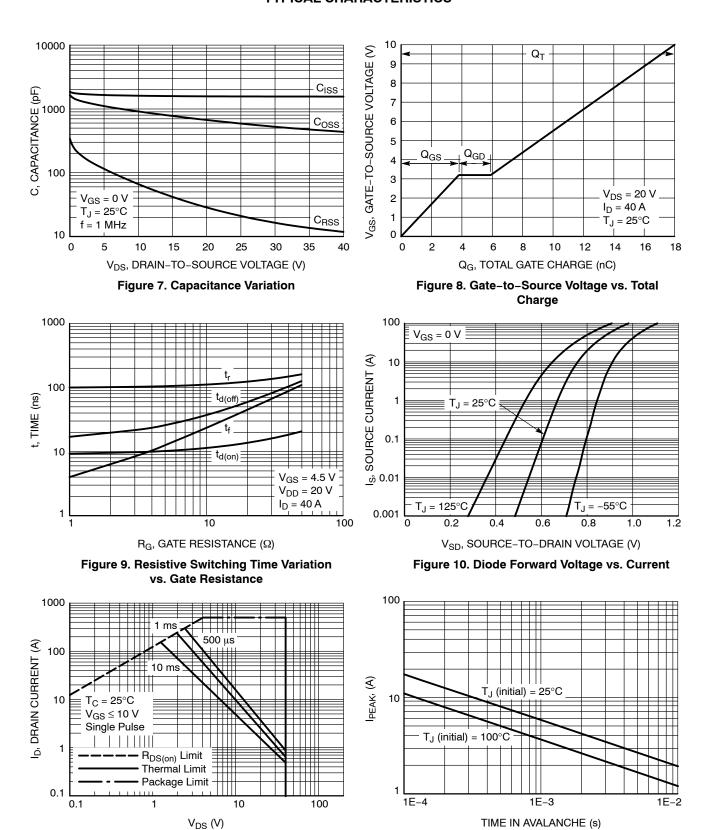


Figure 11. Safe Operating Area

Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

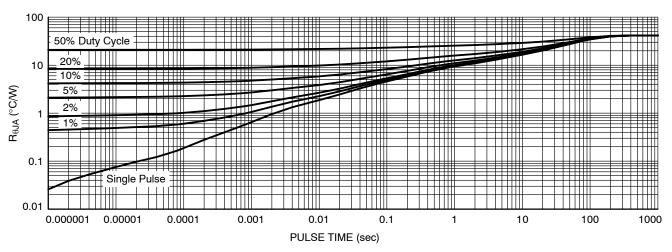


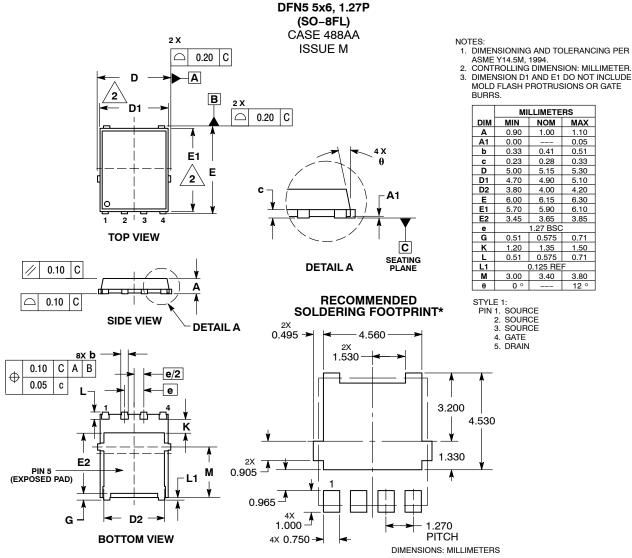
Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS5C456NLT1G	5C456L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C456NLWFT1G	456LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS5C456NLT3G	5C456L	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5C456NLWFT3G	456LWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel
NVMFS5C456NLAFT1G	5C456L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C456NLWFAFT1G	456LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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